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## $\mathbf{K}_{3} \mathrm{TaS}_{4}$

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#### Abstract

The reaction of $\mathrm{K}_{2} \mathrm{~S}_{3}$, Ta and S yields single crystals of tripotassium tetrathiotantalate, $\mathrm{K}_{3} \mathrm{TaS}_{4}$. The compound crystallizes with the $\mathrm{K}_{3} \mathrm{VS}_{4}$-type structure [van den Berg \& de Vries (1964). Proc. K. Ned. Akad. Wet. Ser. B, 67, 178-180]. The structure is based on discrete tetrahedral $\mathrm{TaS}_{4}^{3-}$ anions, which are connected via $\mathrm{K}^{+}$cations.


## Comment

We obtained new ternary alkali niobium chalcogenides with structures that contain the $\mathrm{Nb}_{2} \mathrm{~S}_{11}^{4-}$ anion as a subunit, e.g. $\mathrm{K}_{4} \mathrm{Nb}_{2} \mathrm{~S}_{11}$, via the reaction of niobium in alkali-polychalcogenide fluxes (Bensch \& Dürichen, 1996). Attempts to prepare the analogous tantalum chalcogenides yielded single crystals of the title compound, for which lattice parameters only have been reported (Latroche \& Ibers, 1990). $\mathrm{K}_{3} \mathrm{TaS}_{4}$ is isotypic with $\mathrm{K}_{3} \mathrm{NbS}_{4}, \mathrm{~K}_{3} \mathrm{NbSe}_{4}$ and $\mathrm{K}_{3} \mathrm{TaSe}_{4}$ (Latroche \& Ibers, 1990), as well as with $\mathrm{Cs}_{3} \mathrm{NbSe}_{4}$ and $\mathrm{Cs}_{3} \mathrm{TaSe}_{4}$ (Yun et al., 1988).

The crystal structure of $\mathrm{K}_{3} \mathrm{TaS}_{4}$ is based on discrete tetrahedral $\mathrm{TaS}_{4}^{3-}$ anions which are connected by $\mathrm{K}^{+}$ cations. The Ta-S distances range from 2.264 (3) to 2.269 (2) $\AA$ [average 2.266 (3) $\AA$ ] and the $\mathrm{S}-\mathrm{Ta}-\mathrm{S}$ angles are between $108.48(9)$ and $111.43(12)^{\circ}$.


Fig. 1. The coordination spheres of the $\mathrm{K}^{+}$cations with the coordinating S atoms labelled; displacement ellipsoids are drawn at the $50 \%$ probability level.

The two crystallographically independent $\mathrm{K}^{+}$cations are coordinated by seven S atoms within an irregular polyhedron. K 1 connects four symmetry-related $\mathrm{TaS}_{4}^{3-}$ anions, whereas K2 is surrounded by six symmetryrelated $\mathrm{TaS}_{4}^{3-}$ anions. The $\mathrm{K} 1-\mathrm{S}$ distances range from 3.222 (3) to 3.569 (3) A [average 3.357 (3) $\AA$ ]. K2 exhibits two short K-S distances of 3.139 (3) and 3.285 (4) $\AA$, three medium $\mathrm{K}-\mathrm{S}$ bonds of 3.414 (3), 3.414 (3) and 3.425 (4) $\AA$, and two long $K \cdots S$ contacts of 3.783 (3) A [average 3.463 (4) $\AA$ ].


Fig. 2. The crystal structure viewed along the $b$ axis.

## Experimental

$\mathrm{K}_{3} \mathrm{TaS}_{4}$ was prepared by the reaction of $\mathrm{K}_{2} \mathrm{~S}_{3}$, Ta and S in the ratio 2:1:4. $\mathrm{K}_{2} \mathrm{~S}_{3}$ was prepared from stoichiometric amounts of $K$ and $S$ in liquid ammonia under an argon atmosphere. The starting materials were thoroughly mixed in a dry-box and sealed in a Pyrex-glass ampoule, which was evacuated at $2.7 \times 10^{-13} \mathrm{~Pa}$. The ampoule was heated at 753 K for 6 d , then cooled first to 473 K at $2 \mathrm{~K} \mathrm{~h}^{-1}$ and afterwards to 333 K at $3 \mathrm{~K} \mathrm{~h}^{-1}$. The resulting melt was washed with DMF and the residue was dried in vacuum. Further cleaning was performed by ultrasonic treatment in ethanol.

## Crystal data

$\mathrm{K}_{3} \mathrm{TaS}_{4}$
$M_{r}=426.49$
Orthorhombic

## Pnma

$a=9.315$ (2) $\AA$
$b=10.849$ (2) $\AA$
$c=9.407(2) \AA$
$V=950.7(3) \AA^{3}$
$Z=4$
$D_{x}=2.980 \mathrm{Mg} \mathrm{m}^{-3}$
$D_{m}$ not measured

Mo $K \alpha$ radiation
$\lambda=0.71073 \AA$
Cell parameters from 78 reflections
$\theta=15.5-19.0^{\circ}$
$\mu=13.666 \mathrm{~mm}^{-1}$
$T=293$ (2) K
Prism
$0.10 \times 0.10 \times 0.05 \mathrm{~mm}$ Yellow

## Data collection

Stoe AED-II four-circle diffractometer
$\omega-\theta$ scan
Absorption correction: $\psi$ scan (XEMP in SHELXTLIPC; Siemens, 1990)
$T_{\text {min }}=0.280, T_{\text {max }}=0.505$
1227 measured reflections
1092 independent reflections

1024 reflections with

$$
\begin{aligned}
& I>2 \sigma(I) \\
& R_{\text {int }}=0.027 \\
& \theta_{\max }=27.03^{\circ} \\
& h=0 \rightarrow 11 \\
& k=0 \rightarrow 13 \\
& l=-12 \rightarrow 1
\end{aligned}
$$

4 standard reflections frequency: 120 min intensity decay: $10 \%$

## Refinement

Refinement on $F^{2}$
$R\left[F^{2}>2 \sigma\left(F^{2}\right)\right]=0.030$
$w R\left(F^{2}\right)=0.078$
$S=1.103$
1091 reflections
44 parameters
$w=1 /\left[\sigma^{2}\left(F_{o}^{2}\right)+(0.0353 P)^{2}\right.$
$+11.2664 P]$
where $P=\left(F_{o}^{2}+2 F_{c}^{2}\right) / 3$ $(\Delta / \sigma)_{\max }=0.001$
$\Delta \rho_{\text {max }}=2.761 \mathrm{e}_{\AA^{-3}}$
$\Delta \rho_{\text {min }}=-0.949 \mathrm{e}^{-3}$
Extinction correction: SHELXL93 (Sheldrick, 1993)

Extinction coefficient: 0.0114 (6)

Scattering factors from International Tables for Crystallography (Vol. C)

Table 1. Fractional atomic coordinates and equivalent isotropic displacement parameters ( $\AA^{2}$ )

| $U_{e q}=(1 / 3) \sum_{i} \sum_{j} U^{j j} a^{i} a^{j} \mathbf{a}_{i} \cdot \mathbf{a}_{j}$. |  |  |  |
| :---: | :---: | :---: | :---: |
| $x$ | $y$ | z | $U_{\text {eq }}$ |
| 0.71401 (4) | 1/4 | 0.51297 (4) | 0.0176 (2) |
| 0.5564 (2) | 0.5465 (2) | 0.2895 (2) | 0.0 .326 (4) |
| (0.6388(3) | 1/4 | 0.0827 (3) | 0.0435 (7) |
| 0.4915 (3) | 1/4 | 0.4162 (3) | 0.0322 (6) |
| 0.6918 (3) | 1/4 | 0.7532 (3) | 0.0247 (5) |
| 0.8338(2) | 0.4226 (2) | 0.4471 (2) | 0.0396 (5) |

Table 2. Selected geometric parameters $\left(\AA,{ }^{\circ}\right)$

| Tal-S1 | 2.264 (3) | KI-SI | 3.483 (2) |
| :---: | :---: | :---: | :---: |
| Tal-S3 | 2.266 (2) | K1-Si" | 3.569 (3) |
| Tal-S3 | 2.266 (2) | $\mathrm{K} 2-\mathrm{S} 2^{\prime}$ | 3.139 (3) |
| Tal-S2 | 2.269 (2) | $\mathrm{K} 2-\mathrm{Sl}{ }^{\prime \prime}$ | 3.285 (4) |
| K1-S2 ${ }^{\prime \prime}$ | 3.222 (3) | K2-S3 ${ }^{\prime \prime}$ | 3.414 (3) |
| $\mathrm{K} 1-\mathrm{S} 2^{\text {III }}$ | 3.239 (3) | K2-S3 ${ }^{11}$ | 3.414 (3) |
| K1-S3 | 3.268 (3) | K2-SI | 3.425 (4) |
| $\mathrm{K} 1-\mathrm{S} 3{ }^{\prime \prime}$ | 3.325 (3) | K2 . S $3^{1 / 1}$ | 3.783 (3) |
| K1-S3"' | 3.396 (3) | K2.. S3 ${ }^{\prime \prime \prime}$ | 3.783 (3) |
| $\mathrm{S} 1-\mathrm{Tal}-\mathrm{S} 3^{1}$ | 109.93 (7) | S1-Tal-S2 | 108.48 (9) |
| SI-Tal-S3 | 109.93 (6) | S3 Tal - S2 | 108.49 (7) |
| S3'-Tal-S3 | 111.43 (12) | S3-Tal-S2 | 108.49 (7) |

Symmetry codes: (i) $x, \frac{1}{2}-y$, $z$; (ii) $1-x, 1-y, 1-z$; (iii) $\frac{3}{2}-x, 1-$ $y, z-\frac{1}{2}$; (iv) $x-\frac{1}{2}, y, \frac{1}{2}-z ;$ (v) $x, y, z-1$; (vi) $\frac{1}{2}+x, y, \frac{1}{2}-z ;$ (vii) $x-\frac{1}{2}, \frac{1}{2}-y, \frac{1}{2}-z ;$ (viii) $\frac{3}{2}-x, y-\frac{1}{2}, z-\frac{1}{2}$.

Data were corrected for Lorentz and polarization effects. All $\mathrm{K}, \mathrm{Ta}$ and S atoms were refined with anisotropic displacement parameters. The highest peak in the electron-density map was located $1.11 \AA$ from S3, which cannot be traced back to a disorder of the $\mathrm{TaS}_{4}^{3-}$ anion. In addition, the reciprocal space was thoroughly but unsuccessfully scanned for reflections that might give a hint of the formation of a superstructure.

Data collection: DIF4 (Stoe \& Cie, 1992a). Cell refinement: DIF4. Data reduction: REDU4 (Stoe \& Cie, 1992b). Program(s) used to solve structure: SHELXS86 (Sheldrick, 1990). Program(s) used to refine structure: SHELXL93 (Sheldrick,
1993). Molecular graphics: XP in SHELXTL/PC (Siemens, 1990). Software used to prepare material for publication: CIFTAB in SHELXL93.

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Supplementary data for this paper are available from the IUCr electronic archives (Reference: SK1197). Services for accessing these data are described at the back of the journal.

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## $\left(\mathrm{NH}_{4}\right)_{8}\left[\mathrm{Ce}_{\mathbf{2}}\left(\mathrm{SO}_{4}\right)_{8}\right] . \mathbf{4 H}_{\mathbf{2}} \mathrm{O}$

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#### Abstract

Crystals of the title compound, octaammonium dicerium octasulfate tetrahydrate, suitable for X-ray work, were prepared by a hydrothermal reaction. The structure is made up of $\left[\mathrm{Ce}_{2}\left(\mathrm{SO}_{4}\right)_{8}\right]^{8-}$ anions, interacting with the crystallization waters and the $\mathrm{NH}_{4}^{+}$cations through hydrogen bonds. The $\mathrm{Ce}^{\mathrm{IV}}$ atom in the $\left[\mathrm{Ce}_{2}\left(\mathrm{SO}_{4}\right)_{8}\right]^{8-}$ anion is ninefold coordinated by O atoms belonging to sulfate groups. The coordination polyhedron is a somewhat distorted tricapped trigonal prism. The $\mathrm{Ce}-$ O distances range from 2.325 (2) to 2.478 (2) $\AA$.


## Comment

Sulfates containing cerium(IV) are widely used as oxidants in quantitative analysis and organic chemical synthesis (Toshima \& Yan, 1995). Several structures of cerium(IV) sulfates have been investigated by Lindgren (1976, 1977a,b) in the seventies. Barnes (Barnes, 1995; Barnes et al., 1993) reported the structures of an acid terbium(III) cerium(IV) sulfate hydrate and an acid neodymium(III) ccrium(IV) sulfate hydrate. These structures extend through sulfate bridges to form infinite strings, layers and three-dimensional networks. They contain $\mathrm{Ce}^{\mathrm{IV}}$ ions coordinated by eight or nine O atoms. The coordination polyhedra are of different kinds, e.g. square antiprism, dodecahedron or tricapped trigonal prismatic coordination. In this paper, we report the structure of a new dimeric ammonium cerium(IV) sulfate hydrate. Because cerium(IV) sulfates strongly hydrolyze in aqueous solution, it is difficult to obtain crystals of such compounds under normal conditions. The hydrothermal method was employed to grow single crystals of the title compound.
The dimeric anion, $\left[\mathrm{Ce}_{2}\left(\mathrm{SO}_{4}\right)_{8}\right]^{8-}$, is a distinct chemical unit in the structure. The structure of this anion is shown in Fig. 1. First of all, two sulfate anions act as the bridging groups between the two $\mathrm{Ce}^{\mathrm{IV}}$ ions. The other sulfate anions all act as bidentate terminal ligands. Each $\mathrm{Ce}^{\mathrm{IV}}$ is nine-coordinated, with six O atoms forming a trigonal prism (top face: O13, O8 and O5; bottom face: $\mathrm{O} 11, \mathrm{O} 4$ and O 15 ). The three rectangular faces are each capped by an O atom [O9 ${ }^{\mathrm{i}}, \mathrm{Ol} 0$ and O 3 ; symmetry code: (i) $1-x,-y,-z$ ]. All O atoms coordinated to the $\mathrm{Ce}^{\mathrm{IV}}$ centers are from the sulfate groups. The nine $\mathrm{Ce}-\mathrm{O}$ bond lengths range from 2.325 (2) to 2.478 (2) $\AA$. The $\mathrm{O}-\mathrm{Ce}-\mathrm{O}$ angles, ranging from $56.86(8)$ to $156.44(9)^{\circ}$, are in agreement with those found in similar compounds (Barnes et al., 1993;


Fig. 1. An ORTEP (Johnson. 1965) representation of the title anion. showing $35 \%$ probability displacement ellipsoids and the atomnumbering scheme. The symmetry code is as given in Table 1.

